- Bidirectional Quadruple-Bus Transceivers for Driving MOS Devices
- I/O Ports Have 25-Ω Series Resistors, So No External Resistors Are Required
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (N) 300-mil DIPs

description

This octal buffer and line driver/MOS driver is designed to drive the capacitive inputs of MOS devices and to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. This device features high fan-out and improved fan-in.

The SN74ALS2240 is characterized for operation from 0°C to 70°C.

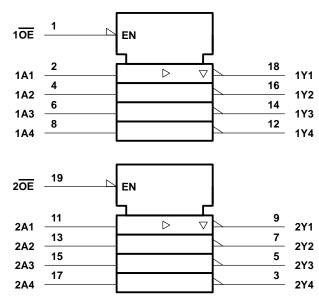
DW OR N PACKAGE (TOP VIEW)

10E [1	O	20] v _{cc}
1A1 [2] 2 0E
2Y4 [3		18	1Y1
1A2 [4		17	2A4
2Y3 [5		16] 1Y2
1A3 [6		15	_
2Y2 [7		14] 1Y3
1A4 [8		13] 2A2
2Y1 [9		12] 1Y4
GND [10		11	2A1

FUNCTION TABLE (each buffer)

INPUTS		OUTPUT
Œ	Α	Y
L	Н	L
L	L	Н
Н	Χ	Z

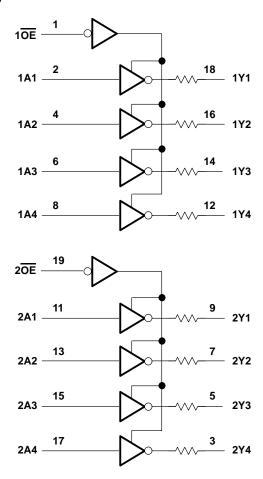
logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



All output resistors are 25 Ω .

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I : All inputs	
I/O ports	5.5 V
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
TA	Operating free-air temperature	0		70	°C



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST COND	ITIONS	MIN TYPT	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA		-1.2	V
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2		V
V	V _{CC} = 4.5 V	I _{OL} = 1 mA	0.15	0.5	V
VoL	∨CC = 4.5 ∨	$I_{OL} = 12 \text{ mA}$	0.35	0.8	٧
IOZH	$V_{CC} = 5.5 V,$	$V_0 = 2.7 \text{ V}$		20	μΑ
lozL	$V_{CC} = 5.5 \text{ V},$	$V_0 = 0.4 V$		-20	μΑ
ΙĮ	V _{CC} = 5.5 V,	V _I = 7 V		0.1	mA
lін	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V		20	μΑ
I _{IL}	$V_{CC} = 5.5 V,$	V _I = 0.4 V		-0.1	mA
1 ₀ ‡	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-30	-112	mA
ЮН	$V_{CC} = 4.5 \text{ V},$	V _O = 2 V	–15		mA
lOL	V _{CC} = 4.5 V,	V _O = 2 V	15		mA
		Outputs high	6	11	
Icc	$V_{CC} = 5.5 V$	Outputs low	13	23	mA
		Outputs disabled	12	20	

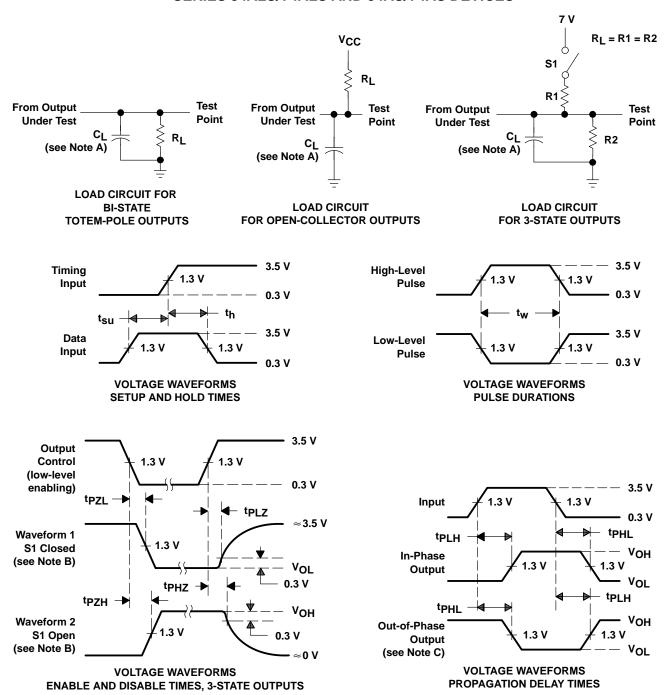
switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 Ω C_L = 50 pF $R1$ = 500 Ω $R2$ = 500 Ω T_A = MIN to	UNIT	
			MIN	MAX	
t _{PLH}	А	~	2	10	ns
^t PHL		1	2	10	115
^t PZH	ŌĒ	Y	5	17	
t _{PZL}		1	7	20	ns
^t PHZ	ŌĒ	~	2	10	ns
t _{PLZ}		1	4	15	115

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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